



P24122.A01

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Ken HIRUNUMA et al.

Group Art Unit : 2872

Serial No : 10/700,496

Examiner : Unknown

Filed : November 5, 2003

For : DIGITAL-CAMERA-PROVIDED BINOCULARS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
PO Box 1450
Alexandria, VA 22313-1450

Sir :

In accordance with the duty of disclosure under C.F.R. §1.56, and §1.97-1.98, Applicants hereby call the following to the Examiner's attention:

Japanese Laid-Open Patent Publication No. 36-12387, published on August 2, 1961,
together with an English language translation of the same;

Japanese Laid-Open Patent Publication No. 57-79909, published on May 19, 1982,
together with an English language translation of the same;

Japanese Laid-Open Patent Publication No. 62-96919, published on May 6, 1987,
together with an English language translation of the same;

Japanese Laid-Open Patent Publication No. 5-2132, published on January 8, 1993,
together with an English language translation of the same;

Japanese Laid-Open Patent Publication No. 6-2330, published on January 14, 1994,
together with an English language translation of the same;

Japanese Laid-Open Patent Publication No. 7-8848, published on February 7, 1995,

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together with an English language translation of the same;

Japanese Laid-Open Patent Publication No. 7-283978, published on October 27, 1995,

together with an English language translation of the same;

Japanese Laid-Open Patent Publication No. 11-248996, published on September 17,

1999, together with an English language Abstract of the same;

Japanese Patent Publication No. 2624556, published on April 11, 1997, together with an English language translation of the same;

Japanese Laid-Open Patent Publication No. 2001-281555, published on October 10 2001,
together with English language counterpart U.S. Patent Application Publication No.
2001/0028498 to HAGA et al., published on October 11, 2001;

Japanese Laid-Open Patent Publication No. 2001-311868, published on November 9,
2001, together with an English language Abstract of the same;

International Application No. WO 01/52531 A1, published on July 19, 2001;

U.S. Patent No. 4,067,027 to YAMAZAKI, issued on January 2, 1978;

U.S. Patent No. 4,262,988 to ISHIBAI et al., issued on April 21, 1981;

U.S. Patent No. 4,400,065 to NAGLER, issued on August 23, 1983;

U.S. Patent No. 5,583,692 to FUNATSU, issued on December 10, 1996;

U.S. Patent No. 5,729,390 to ABE, issued on March 17, 1998;

U.S. Patent No. 5,926,657 to HASUSHITA, issued on July 20, 1999;

U.S. Patent No. 6,088,053 to HAMMACK et al., issued on July 11, 2000, which is a
family member of above noted international Application No WO 01/52531;

U.S. Patent Application Publication No. 2003-0072567 to ABE, which published on

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April 17, 2003;

U.S. Patent Application Publication No. 2003-0072091 to ABE, which published on April 17, 2003;

U.S. Patent Application Publication No. 2003-0063382 to HIRUNUMA et al., which published on April 3, 2003;

U.S. Patent Application Publication No. 2003-0063381 to ABE, which published on April 3, 2003;

U.S. Patent Application Publication No. 2003-0086164 to ABE, which published on May 8, 2003;

U.S. Patent Application Publication No. 2003-0063209 to ENOMOTO et al., which published on April 3, 2003;

U.S. Patent Application Publication No. 2003-0063189 to HIRUNUMA et al., which published on April 3, 2003;

U.S. Patent Application Publication No. 2003-0063380 to HIRUNUMA et al., which published on April 3, 2003;

U.S. Patent Application Publication No. 2003-0151807 to HIRUNUMA et al., which published on August 14, 2003;

U.S. Patent Application Publication No. 2003-0151808 to HIRUNUMA et al., which published on August 14, 2003; and

U.S. Patent Application Publication No. 2003-0151660 to HIRUNUMA et al., which published on August 14, 2003.

Applicant respectfully requests that the Examiner consider the above materials and cite

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the patent documents and enclosed translations. Copies of the above-noted documents have been listed on a PTO-1449 Form which is also attached hereto. Accordingly, the Examiner is requested to initial the appropriate spaces on the attached PTO-1449 Form and to return a copy of the Form to the Applicant with the next official communication in the present application to confirm consideration of these documents.

Further to the U.S. Patent and Trademark Office's decision to waive the requirement under 37 C.F.R. 1.98 (a)(2)(i), copies of the U.S. patents and U.S. patent application publications are not enclosed herewith. Thus, only copies of the above-noted foreign documents are enclosed. However, if copies of any of the above-noted documents are needed, the Examiner is respectfully requested to contact the undersigned.

Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully submitted,
Ken HIRUNUMA

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Form PTO-1449 INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	U.S. Department of Commerce Patent and Trademark Office								Atty. Docket No. P24122	Serial No. 10/700,496
									Applicant Ken HIRUNUMA et al.	
									Filing Date November 5, 2003	Group 2872

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	2001 /	0	0	2	8	4	9	8	10/11/01	HAGA et al.			
		4	0	6	7	0	2	7	01/02/78	YAMAZAKI			
		4	2	6	2	9	8	8	04/21/81	ISHIBAI et al.			
		4	4	0	0	0	6	5	08/23/83	NAGLER			
		5	5	8	3	6	9	2	12/10/96	FUNATSU			
		5	7	2	9	3	9	0	03/17/98	ABE			
		5	9	2	6	6	5	7	07/20/99	HASUSHITA			
		6	0	8	8	0	5	3	07/11/00	HAMMACK et al.			
	2003 /	0	0	7	2	5	6	7	04/17/03	ABE			

FOREIGN PATENT DOCUMENTS

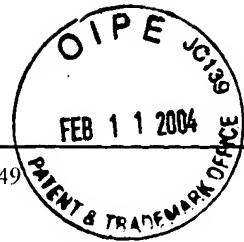
		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
		3	6	-	-	2	3	8	7	08/02/61	JAPAN			X
		5	7	-	7	9	9	0	9	05/19/82	JAPAN			X
		6	2	-	9	6	9	1	9	05/06/87	JAPAN			X
			5	-	2		1	3	2	01/08/93	JAPAN			X
			6	-	2		3	3	0	01/14/94	JAPAN			X
			7	-	8		8	4	8	02/07/95	JAPAN			X
		7	-	2	8	3	9	7	8	10/27/95	JAPAN			X
		11	-	2	4	8	9	9	6	09/17/99	JAPAN			
		2	6	2	4	5	5	6	04/11/97	JAPAN				X
	2001	-	2	8	1	5	5	5	10/10/01	JAPAN				
	2001	-	3	1	1	8	6	8	11/09/01	JAPAN				
	0	1	/	5	2	5	3	1	07/19/01	W.I.P.O.				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	1	English Language Abstract of JP 11-248996.
	2	English Language Abstract of JP 2001-311868.

EXAMINER	DATE CONSIDERED
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*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form PTO-1449		U.S. Department of Commerce Patent and Trademark Office							Atty. Docket No. P24122		Serial No. 10/700,496	
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	2003 /	0	0	7	2	0	9	1	04/17/03	ABE		
	2003 /	0	0	6	3	3	8	2	04/03/03	HIRUNUMA et al.		
	2003 /	0	0	6	3	3	8	1	04/03/03	ABE		
	2003 /	0	0	8	6	1	6	4	05/08/03	ABE		
	2003 /	0	0	6	3	2	0	9	04/03/03	ENOMOTO et al.		
	2003 /	0	0	6	3	1	8	9	04/03/03	HIRUNUMA et al.		
	2003 /	0	0	6	3	3	8	0	04/03/03	HIRUNUMA et al.		
	2003 /	0	1	5	1	8	0	7	08/14/03	HIRUNUMA et al.		
	2003 /	0	1	5	1	8	0	8	08/14/03	HIRUNUMA et al.		
	2003 /	0	1	5	1	6	6	0	08/14/03	HIRUNUMA et al.		
	2003 /	0	2	0	2	1	1	8	10/30/03	HURUNUMA et al.		

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER				DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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